Notice of References Cited Application/Control No. 10/670,101 Examiner Edward Wojciechowicz Applicant(s)/Patent Under Reexamination MURDUCK ET AL. Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2005/0040493	02-2005	Yeo et al.	257/536
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